

| | | | | |
|-----------------------------------|---------------------------------------|--|--|-------------|
| Notice of References Cited | Application/Control No. 10/598,194 | | Applicant(s)/Patent Under Reexamination SUDAKOV ET AL. | |
| | Examiner MICHAEL J. LOGIE | | Art Unit 2881 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-----------------|----------------|
| * | A | US-5,763,878 A | 06-1998 | Franzen, Jochen | 250/292 |
| * | B | US-6,380,666 B1 | 04-2002 | Kawato, Eizo | 313/359.1 |
| * | C | US-2003/0066958 A1 | 04-2003 | Okumura et al. | 250/286 |
| * | D | US-2004/0026613 A1 | 02-2004 | Bateman et al. | 250/281 |
| * | E | US-6,900,433 B2 | 05-2005 | Ding, Li | 250/292 |
| * | F | US-6,977,374 B2 | 12-2005 | Kawato, Eizo | 250/292 |
| * | G | US-6,989,534 B2 | 01-2006 | Schubert et al. | 250/292 |
| * | H | US-7,297,960 B2 | 11-2007 | Brown et al. | 250/396R |
| * | I | US-7,501,622 B2 | 03-2009 | Kawato, Eizo | 250/292 |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | I | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.